

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/692,854 KANEKO ET AL.	
		Examiner	Art Unit	Page 1 of 1 Tran N. Nguyen 2834

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,759,778	07-2004	Nishiyama et al.	310/156.53
	C	US-2005/0040716	02-2005	Schmid et al.	310/071
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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